Memory

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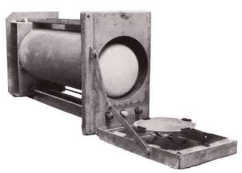
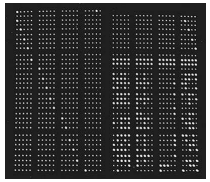
Early Memories



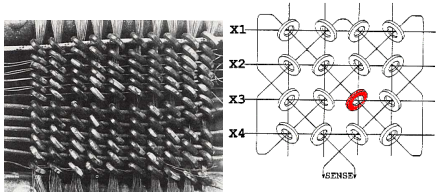


Williams Tube CRT-based random access memory, 1946. Used on the Manchester Mark I. 2048 bits.

Early Memories

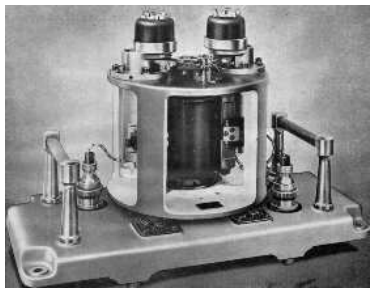
Mercury acoustic delay line.
Used in the EDASC, 1947.
32×17 bits

Early Memories



Magnetic core memory, 1952. IBM.

Early Memories

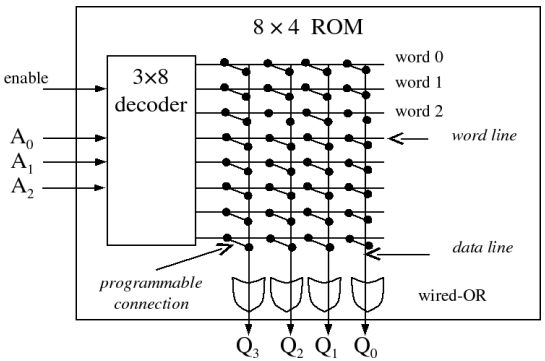


Magnetic drum memory. 1950s & 60s.
Secondary storage.

Modern Memory Choices

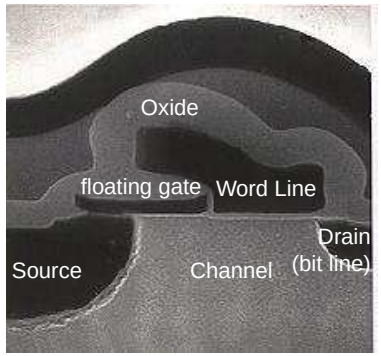
Family	Programmed	Persistence
Mask ROM	at fabrication	∞
PROM	once	∞
EPROM	1000s, UV	10 years
FLASH	1000s, block	10 years
EEPROM	1000s, byte	10 years
NVRAM	∞	5 years
SRAM	∞	while powered
DRAM	∞	64 ms

ROMs



EPROMs

EEPROM and FLASH



Slow write

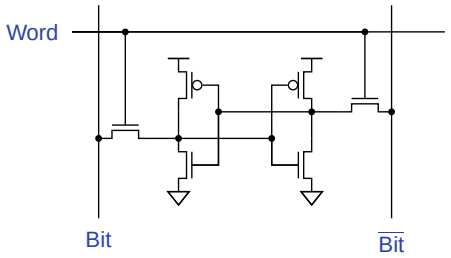
Fowler-Nordheim Tunneling

EEPROM: bit at a time

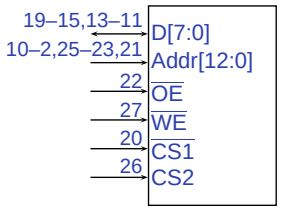
FLASH: block at a time

Source: SST

Static RAM Cell



Standard SRAM: 6264

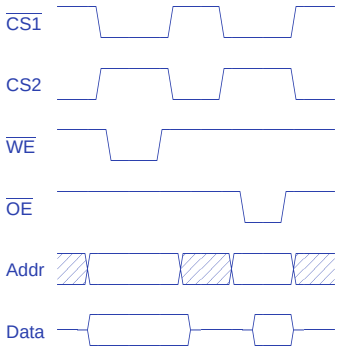


8K $\times$ 8

Can be very fast: Cypress sells a 55ns version

Simple, asynchronous interface

Standard SRAM: 6264



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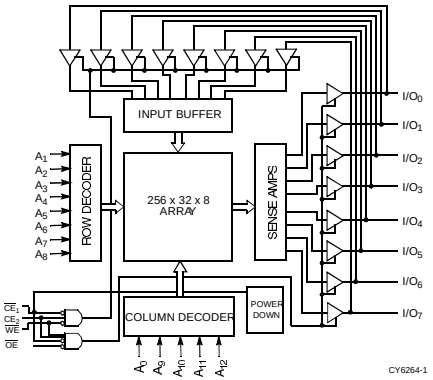
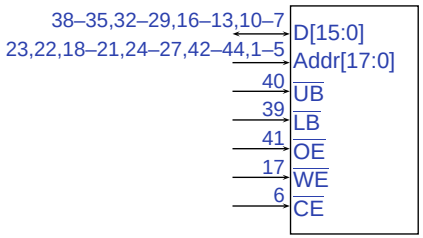


Toshiba TC55V16256J 256K $\times$ 16

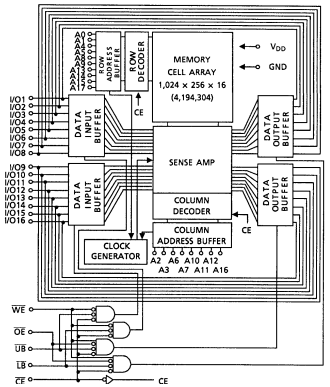


12 or 15 ns access time

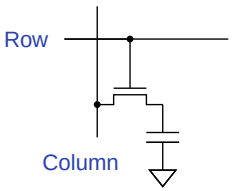
Asynchronous interface

$\overline{\text{UB}}$, $\overline{\text{LB}}$ select bytes

Toshiba TC55V16256J 256K $\times$ 16



Dynamic RAM Cell



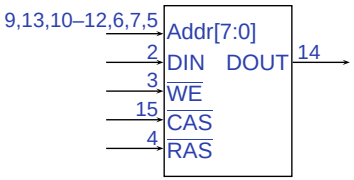
Basic problem: Leakage

Solution: Refresh

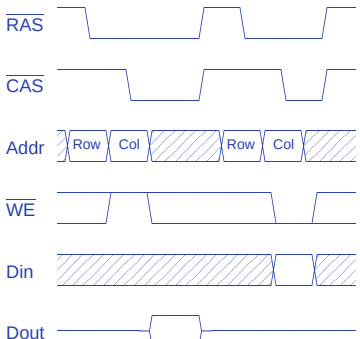
Ancient DRAM: 4164

64K $\times$ 1

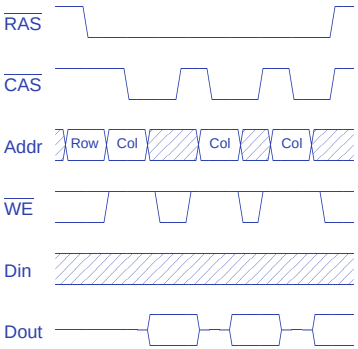
Apple IIe vintage



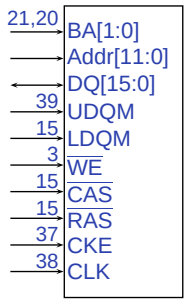
Basic DRAM read and write cycles



Page mode read cycle



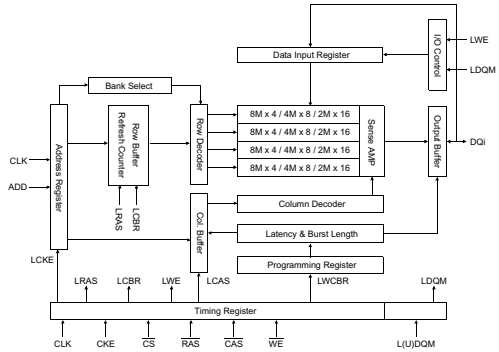
Samsung 8M × 16 SDRAM



Bank address
Address (multiplexed)
Data I/O
Upper byte enable
Lower byte enable
Write enable
Column Address Strobe
Row Address Strobe
Clock Enable
Clock

Synchronous interface
Designed for burst-mode operation
Four separate banks; pipelined operation

Samsung 8M × 16 SDRAM



SDRAM: Control Signals

RAS	CAS	WE	action
1	1	1	NOP
0	0	0	Load mode register
0	1	1	Active (select row)
1	0	1	Read (select column, start burst)
1	0	0	Write (select column, start burst)
1	1	0	Terminate Burst
0	1	0	Precharge (deselect row)
0	0	1	Auto Refresh

Mode register: selects 1/2/4/8-word bursts, CAS latency, burst on write

SDRAM: Timing with 2-word bursts